

### IGBT<sup>3</sup> Chip

#### **FEATURES:**

- 1200V Trench + Field Stop technology
- 120µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

#### This chip is used for:

• power module



#### Applications:

• drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC158T120R3L	1200V	150A	12.56 x 12.56 mm <sup>2</sup>	sawn on foil	Q67050- A4211-A101

#### **MECHANICAL PARAMETER:**

Raster size	12.56 x 12.56				
Emitter pad size ( include gate pad )	11.04 x 11.04				
Gate pad size	1.14 x 1.14				
Area total / active	157.8 / 128.1				
Thickness	120	μm			
Wafer size	150	mm			
Flat position	90	grd			
Max.possible chips per wafer	86 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm AlSiCu				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, <500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	Α
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	450	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

## STATIC CHARACTERISTICS (tested on chip), $T_{j}$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
- arameter		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ = 6 mA	1200			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =150A	1.35	1.65	2.05	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I <sub>C</sub> =6mA , V <sub>GE</sub> =V <sub>CE</sub>	5.0	5.8	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			20	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			600	nA
Integrated gate resistor	R <sub>Gint</sub>			5		Ω

#### **ELECTRICAL CHARACTERISTICS** (tested at component):

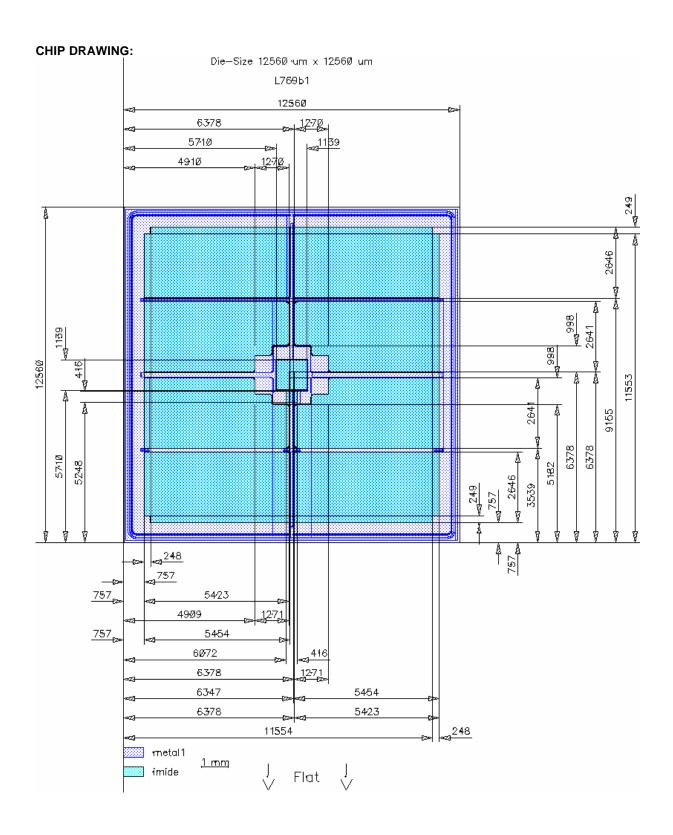
Parameter	Symbol	Conditions	Value			Unit
rarameter			min.	typ.	max.	Onne
Input capacitance	Ciss	V <sub>CE</sub> =25V,		10766		pF
Output capacitance	Coss	$V_{GE}=0V$ ,		563		
Reverse transfer capacitance	Crss	f=1MHz		488		

#### SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =125°C		0.29		μs
Rise time	t <sub>r</sub>	$V_{CC} = 600 \text{V},$ $I_{C} = 150 \text{A},$		0.05		
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE} = -15/15  \rm V$		0.52		
Fall time	$t_{f}$	$R_{\rm G}$ = 2.4 $\Omega$		0.09		

<sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.







# This chip data sheet refers to the device data sheet DESCRIPTION: AQL 0,65 for visual inspection according to failure catalog Electrostatic Discharge Sensitive Device according to MIL-STD 883

Published by Infineon Technologies AG, Bereich Kommunikation St.-Martin-Strasse 53, D-81541 München © Infineon Technologies AG 2002 All Rights Reserved.

Test-Normen Villach/Prüffeld

#### Attention please!

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

#### Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives world-wide (see address list).

#### Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and / or maintain and sustain and / or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.